Fast Compton

Inverse Compton produced x-rays for structural dynamics

Oliver Williams ATF Users Meeting October 2010

Energy Measurement Using K-edge

- Characterized x-rays via K-edge foil
- ICS photons have angular-energy relation (undulator eqn.):





Analyzing the photons







72 MeV

70 MeV



68 MeV





66 MeV

65 MeV



64 MeV

Lobe observation angle



Fit simulation curve to data by adding energy offset (~290 eV)

-Energy offset could be due to absolute e-beam energy calibration or nonlinear induced red-shifting $(a_L>0)$ (more likely)

-Nonlinear effects would then dominate bandwidth: 4%

Circular polarization and sub-ps pulses



~2x10⁶ photons over 1 mrad (1x10⁸ full angle) in a modest 300 fs pulse

Dynamics: Where ICS shines...

- Pump-probe and living samples require data in a single shot
- Can't compete with avg. brightness of synchrotrons, but...
- ICS capable of delivering high flux in single sub-ps pulse
- Tunability of energy and polarization allows for range of ultra-fast applications: lattice changes, magnetic materials dynamics, chemical processes, etc.



Melting of InSb K.J. Gaffney, et al., PRL 95, 125701 (2005)

Is "Fast Compton" Possible?

- Need to show feasibility of Compton as ultra-fast x-ray source
- Requires a "basic" study to understand pump-probe synchronization
- Will watch non-thermal melting of Ge-layer on Si-substrate (bulk crystal won't reveal melted surface by diffracted x-rays)
- Preferential absorption of 800 nm pump by x-ray probed Ge layer
- 1st: Static Diffraction
- 2nd: Time stamp e-beam (x-ray) arrival time = Electro-optic sampling (EOS)



Linde, et al., J. Phys. Cond. Matter 16 (2004)

Lattice Dynamics

- Compressed e-beam can (presumably) produce 100 fs x-rays
- Allows sub-ps probe of lattice changes in non-thermal melting of Ge
- Look for decrease in diffracted signal
- Recreating known experiment can put upper bounds on x-ray pulse length = temporal diagnostic



Chapter 1: Static Diffraction (Bragg Condition : λ =2dsin θ)

- Measurement of central photon energy made using Ni-foil method
- Shows ~8.6 keV photons on axis
- Start with Si-crystal: cheap, Bragg angle near our energy, part of exp!
- Given Si lattice spacing of 2d=6.28, have θ=13.3 deg.



Single-shot Static Diffraction





 50

 100

 150

 200

 201

 202

 300

 350

 400

 450

 100
 200

 300
 400

 500

 100
 200

 300
 400

 500
 500

Θ=13.5 degrees



Θ=13.8 degrees ("8.28 keV")

Θ=13.7 degrees

Diffraction lessons learned

- Observed diffraction signal in 250 eV window (as dictated by Bragg angle)
- Corresponds to expected bandwidth given in simulation and K-edge measurements
- Central energy not exactly right: very possibly due to non-normal incidence angle on crystal
- Higher resolution detector/camera may be needed for melting experiments

Electro-optic sampling

- Use nonlinear crystal (e.g. ZnTe <110>)
- E-field of electron bunch imprinted on crystal
- Acts as polarization gate
- resolution: probe laser pulse length and crystal thickness
- Time window: crystal width and laser spot size
- Provocation based on measurements done at UCLA Pegasus Lab



C. M. Scoby, et al., PRSTAB 13, 022801 (2010)

Summary

- Fairly good confidence in deliverable x-ray energy using two different diagnostics
- To our knowledge, 1st observation of single shot static diffraction from a Compton source
- Use new Ti:Sa laser for pump AND time-stamping of x-ray arrival time due to system jitter
- Experience with EOS will carry to other experiments requiring tight synchronization requirements
- Will demonstrate feasibility of ATF Compton source for ultra-fast science